

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination RAVA ET AL.	
		Examiner Ruth S. Smith	Art Unit 3737	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,115,137	05-1992	Andersson-Engels et al.	250/461.2
*	B	US-5,261,410	11-1993	Alfano et al.	600/475
*	C	US-4,718,417	01-1988	Kittrell et al.	606/7
*	D	US-4,810,875	03-1989	Wyatt, Philip J.	250/227.11
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
*	U	Williamson et al., "Near-Infrared Raman Spectroscopy with a 783-nm Diode Laser and CCD Array Detector" Applied Spectroscopy, 43(3) pp372-375 1989		
	V			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.